

### Short circuit rugged 1200 V TRENCHSTOP™ IGBT 7 technology copacked with soft, fast recovery Emitter Controlled 7 diode

#### Features

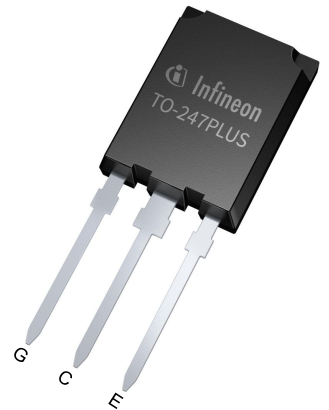
- $V_{CE} = 1200\text{ V}$
- $I_C = 75\text{ A}$
- IGBT co-packed with full current, soft and low  $Q_{rr}$  diode
- Low saturation voltage  $V_{CEsat} = 2.0\text{ V}$  at  $T_{vj} = 175^\circ\text{C}$
- Optimized for hard switching topologies (2-L inverter, 3-L NPC T-type, ...)
- Short circuit ruggedness  $8\ \mu\text{s}$
- Wide range of  $dv/dt$  controllability
- Complete product spectrum and PSpice Models: <http://www.infineon.com/igbt/>

#### Potential applications

- Industrial drives
- Industrial power supplies
- Solar inverters

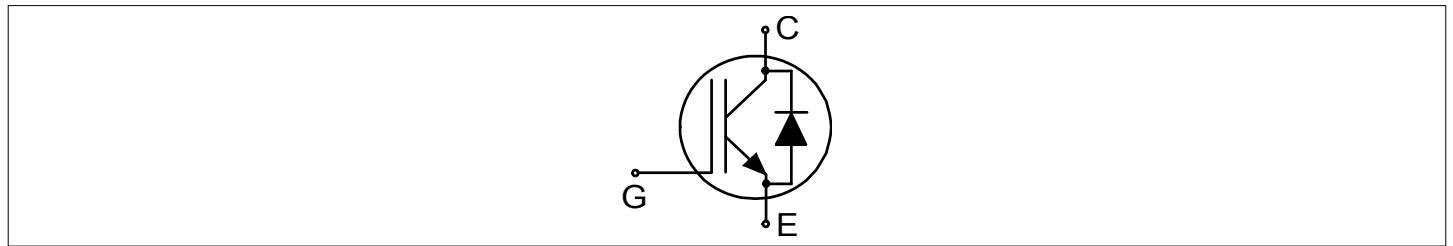
#### Product validation

- Qualified for industrial applications according to the relevant tests of JEDEC47/20/22



- Halogen-free
- Lead-free
- Green
- RoHS

#### Description



Type	Package	Marking
IKQ75N120CS7	PG-TO247-3-PLUS-NN3.7	K75MCS7

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## 1 Package

**Table 1** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Internal emitter inductance measured 5 mm (0.197 in.) from case	$L_E$			13		nH
Storage temperature	$T_{stg}$		-55		150	°C
Soldering temperature	$T_{sold}$	wave soldering 1.6 mm (0.063 in.) from case for 10 s			260	°C
Thermal resistance, junction-ambient	$R_{th(j-a)}$				40	K/W
IGBT thermal resistance, junction-case	$R_{th(j-c)}$			0.17	0.24	K/W
Diode thermal resistance, junction-case	$R_{th(j-c)}$			0.31	0.42	K/W

## 2 IGBT

**Table 2** Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Collector-emitter voltage	$V_{CE}$	$T_{vj} \geq 25\text{ °C}$	1200	V	
DC collector current, limited by $T_{vjmax}$	$I_C$	limited by bondwire	$T_c = 25\text{ °C}$	154	A
			$T_c = 100\text{ °C}$	103	
Pulsed collector current, $t_p$ limited by $T_{vjmax}$	$I_{Cpulse}$		225	A	
Turn-off safe operating area		$V_{CE} \leq 1200\text{ V}, T_{vj} \leq 175\text{ °C}$	225	A	
Gate-emitter voltage	$V_{GE}$		±20	V	
Transient gate-emitter voltage	$V_{GE}$	$t_p \leq 0.5\text{ }\mu\text{s}, D < 0.001$	±25	V	
Short-circuit withstand time	$t_{SC}$	$V_{CC} \leq 600\text{ V}, V_{GE} = 15\text{ V}$ , Allowed number of short circuits < 1000, Time between short circuits $\geq 1.0\text{ s}, T_{vj} = 150\text{ °C}$	8	μs	
Power dissipation	$P_{tot}$	$T_{vj} \leq 175\text{ °C}$	$T_c = 25\text{ °C}$	630	W
			$T_c = 100\text{ °C}$	315	

**Table 3 Characteristic values**

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Collector-emitter saturation voltage	$V_{CEsat}$	$I_C = 75\text{ A}, V_{GE} = 15\text{ V}$	$T_{vj} = 25\text{ °C}$		1.65	2	V
			$T_{vj} = 175\text{ °C}$		2		
Gate-emitter threshold voltage	$V_{GETh}$	$I_C = 1.5\text{ mA}, V_{CE} = V_{GE}$		5.1	5.7	6.5	V
Zero gate-voltage collector current	$I_{CES}$	$V_{CE} = 1200\text{ V}, V_{GE} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$			40	$\mu\text{A}$
			$T_{vj} = 175\text{ °C}$		6600		
Gate-emitter leakage current	$I_{GES}$	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V}$				100	nA
Transconductance	$g_{fs}$	$I_C = 75\text{ A}, V_{CE} = 20\text{ V}, T_{vj} = 175\text{ °C}$			30		S
Short-circuit collector current	$I_{SC}$	$V_{CC} \leq 600\text{ V}, V_{GE} = 15\text{ V}, t_{SC} \leq 8\text{ }\mu\text{s}$ , Allowed number of short circuits < 1000, Time between short circuits $\geq 1.0\text{ s}$ , $T_{vj} = 150\text{ °C}$			450		A
Input capacitance	$C_{ies}$	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 100\text{ kHz}$			11.2		nF
Output capacitance	$C_{oes}$	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 100\text{ kHz}$			210		pF
Reverse transfer capacitance	$C_{res}$	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 100\text{ kHz}$			50		pF
Gate charge	$Q_G$	$I_C = 75\text{ A}, V_{GE} = 15\text{ V}, V_{CC} = 960\text{ V}$			450		nC
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{G(on)} = 2.1\text{ }\Omega, R_{G(off)} = 2.1\text{ }\Omega$	$T_{vj} = 25\text{ °C}, I_C = 75\text{ A}$		38		ns
			$T_{vj} = 175\text{ °C}, I_C = 75\text{ A}$		36		
Rise time (inductive load)	$t_r$	$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{G(on)} = 2.1\text{ }\Omega, R_{G(off)} = 2.1\text{ }\Omega$	$T_{vj} = 25\text{ °C}, I_C = 75\text{ A}$		23		ns
			$T_{vj} = 175\text{ °C}, I_C = 75\text{ A}$		26		
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{G(on)} = 2.1\text{ }\Omega, R_{G(off)} = 2.1\text{ }\Omega$	$T_{vj} = 25\text{ °C}, I_C = 75\text{ A}$		190		ns
			$T_{vj} = 175\text{ °C}, I_C = 75\text{ A}$		253		
Fall time (inductive load)	$t_f$	$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{G(on)} = 2.1\text{ }\Omega, R_{G(off)} = 2.1\text{ }\Omega$	$T_{vj} = 25\text{ °C}, I_C = 75\text{ A}$		107		ns
			$T_{vj} = 175\text{ °C}, I_C = 75\text{ A}$		230		
Turn-on energy	$E_{on}$	$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{G(on)} = 2.1\text{ }\Omega, R_{G(off)} = 2.1\text{ }\Omega$	$T_{vj} = 25\text{ °C}, I_C = 75\text{ A}$		5.13		mJ
			$T_{vj} = 175\text{ °C}, I_C = 75\text{ A}$		7.32		

**(table continues...)**

**Table 3 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-off energy	$E_{off}$	$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V},$ $R_{G(on)} = 2.1\ \Omega,$ $R_{G(off)} = 2.1\ \Omega$	$T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 75\text{ A}$		3.48	mJ
			$T_{vj} = 175\text{ }^\circ\text{C},$ $I_C = 75\text{ A}$		6.48	
Total switching energy	$E_{ts}$	$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V},$ $R_{G(on)} = 2.1\ \Omega,$ $R_{G(off)} = 2.1\ \Omega$	$T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 75\text{ A}$		8.6	mJ
			$T_{vj} = 175\text{ }^\circ\text{C},$ $I_C = 75\text{ A}$		13.8	
Operating junction temperature	$T_{vj}$		-40		175	$^\circ\text{C}$

Note: Electrical Characteristic, at  $T_{vj} = 25\text{ }^\circ\text{C}$ , unless otherwise specified.

### 3 Diode

**Table 4 Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit	
Diode forward current, limited by $T_{vjmax}$	$I_F$		$T_c = 25\text{ }^\circ\text{C}$	126	A
			$T_c = 100\text{ }^\circ\text{C}$	83	
Diode pulsed current, $t_p$ limited by $T_{vjmax}$	$I_{Fpulse}$		225	A	
Power dissipation	$P_{tot}$		$T_c = 25\text{ }^\circ\text{C}$	356	W
			$T_c = 100\text{ }^\circ\text{C}$	178	

**Table 5 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Diode forward voltage	$V_F$	$I_F = 75\text{ A}$	$T_{vj} = 25\text{ }^\circ\text{C}$		1.65	2.15	V
			$T_{vj} = 175\text{ }^\circ\text{C}$		1.6		
Diode reverse recovery time	$t_{rr}$	$V_R = 600\text{ V}, R_{G(on)} = 2.1\ \Omega$	$T_{vj} = 25\text{ }^\circ\text{C},$ $I_F = 75\text{ A}$		193	ns	
			$T_{vj} = 175\text{ }^\circ\text{C},$ $I_F = 75\text{ A}$		313		
Diode reverse recovery charge	$Q_{rr}$	$V_R = 600\text{ V}, R_{G(on)} = 2.1\ \Omega$	$T_{vj} = 25\text{ }^\circ\text{C},$ $I_F = 75\text{ A}$		5.26	$\mu\text{C}$	
			$T_{vj} = 175\text{ }^\circ\text{C},$ $I_F = 75\text{ A}$		10.9		

(table continues...)

**Table 5 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Diode peak reverse recovery current	$I_{rrm}$	$V_R = 600\text{ V}, R_{G(on)} = 2.1\ \Omega$	$T_{vj} = 25\text{ °C}, I_F = 75\text{ A}$		51		A
			$T_{vj} = 175\text{ °C}, I_F = 75\text{ A}$		65		
Diode peak rate of fall of reverse recovery current	$di_{rr}/dt$	$V_R = 600\text{ V}, R_{G(on)} = 2.1\ \Omega$	$T_{vj} = 25\text{ °C}, I_F = 75\text{ A}$		-345		A/ $\mu\text{s}$
			$T_{vj} = 175\text{ °C}, I_F = 75\text{ A}$		-245		
Reverse recovery energy	$E_{rec}$	$V_R = 600\text{ V}, R_{G(on)} = 2.1\ \Omega$	$T_{vj} = 25\text{ °C}, I_F = 75\text{ A}$		1.7		mJ
			$T_{vj} = 175\text{ °C}, I_F = 75\text{ A}$		3.84		
Operating junction temperature	$T_{vj}$		-40		175	$^{\circ}\text{C}$	

**Note:** For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

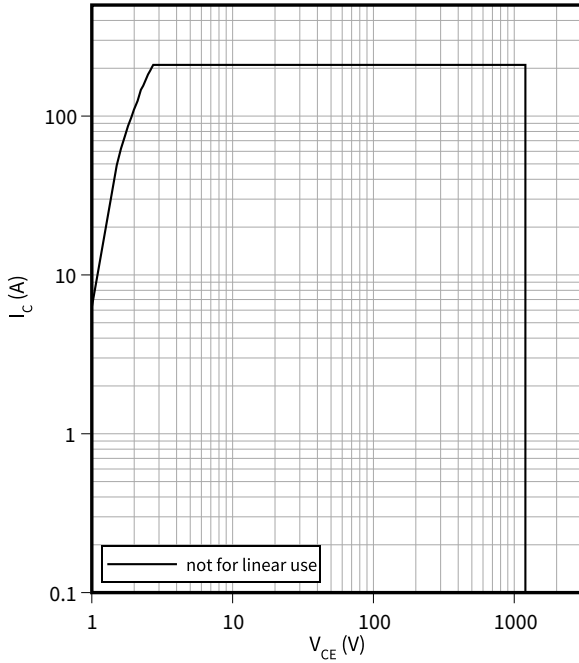
Dynamic test circuit, parasitic inductance  $L_{\sigma} = 30\text{ nH}$ ,  $C_{\sigma} = 18\text{ pF}$ .

## 4 Characteristics diagrams

### Reverse bias safe operating area

$$I_C = f(V_{CE})$$

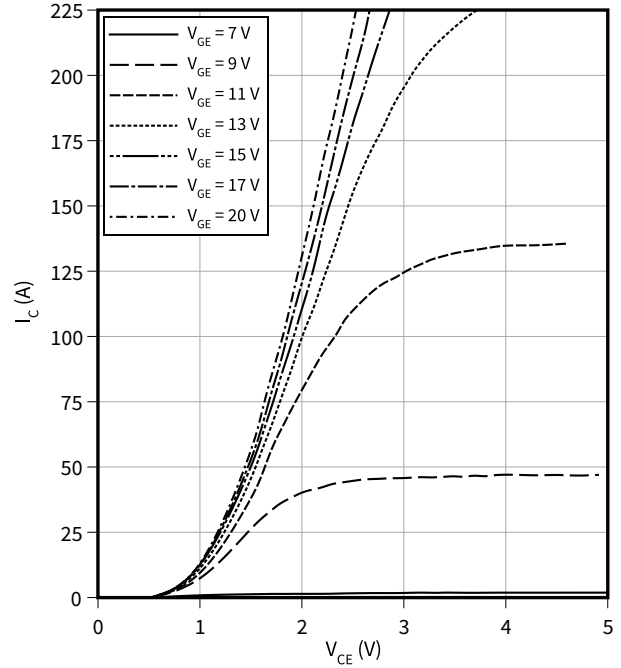
$$T_{vj} \leq 175\text{ °C}, V_{CE} \leq 1200\text{ V}$$



### Typical output characteristic

$$I_C = f(V_{CE})$$

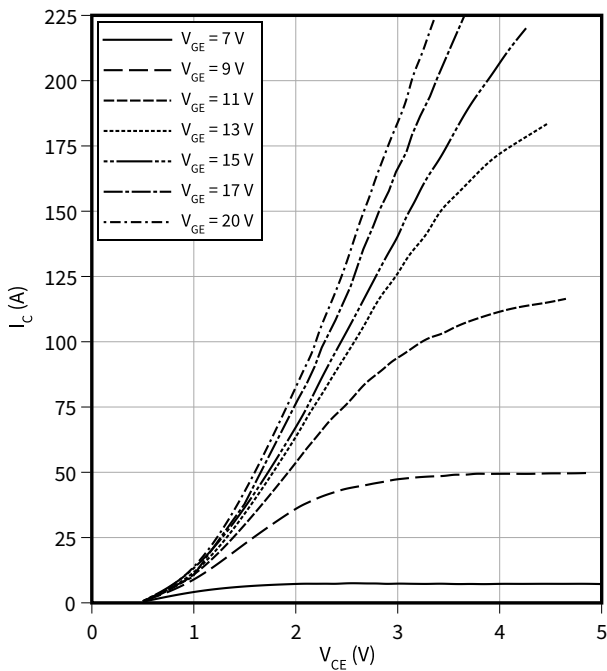
$$T_{vj} = 25\text{ °C}$$



### Typical output characteristic

$$I_C = f(V_{CE})$$

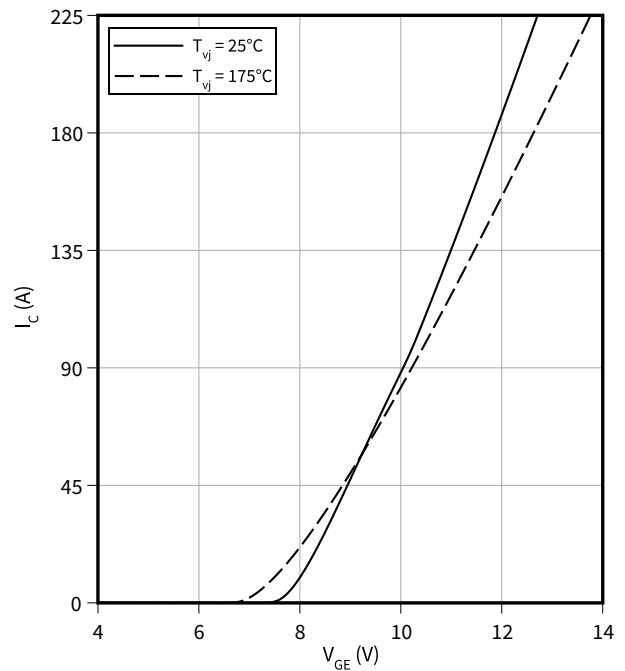
$$T_{vj} = 175\text{ °C}$$



### Typical transfer characteristic

$$I_C = f(V_{GE})$$

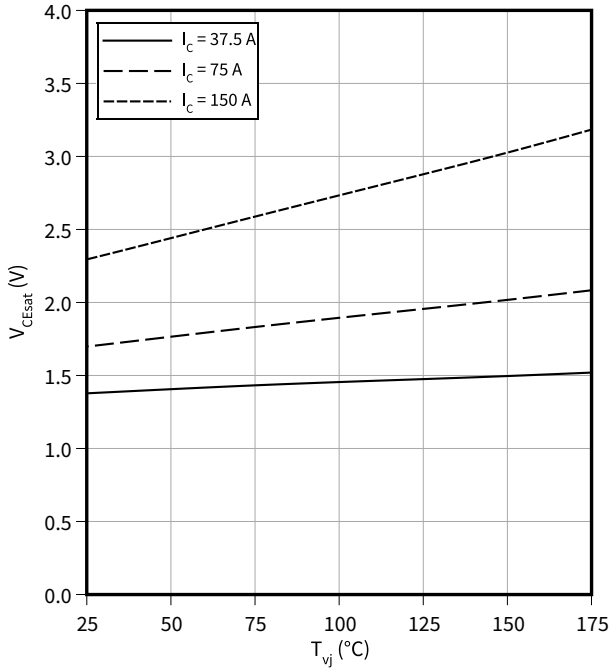
$$V_{CE} = 20\text{ V}$$



4 Characteristics diagrams

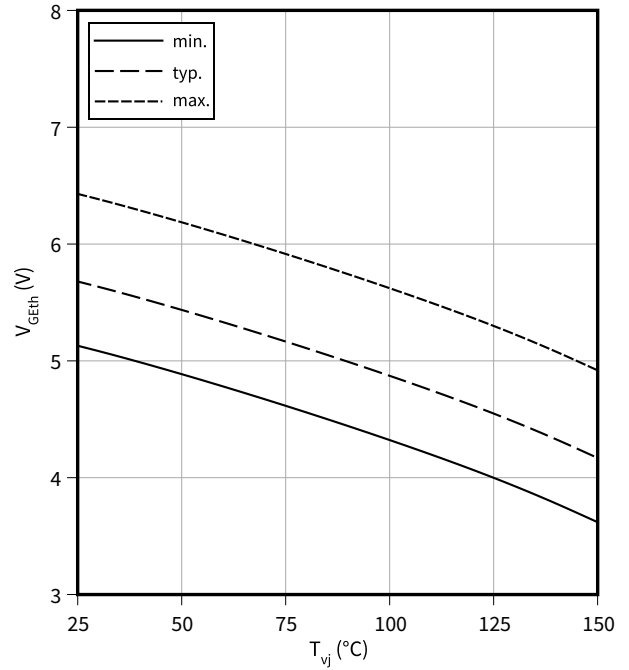
**Typical collector-emitter saturation voltage as a function of junction temperature**

$V_{CEsat} = f(T_{vj})$   
 $V_{GE} = 15\text{ V}$



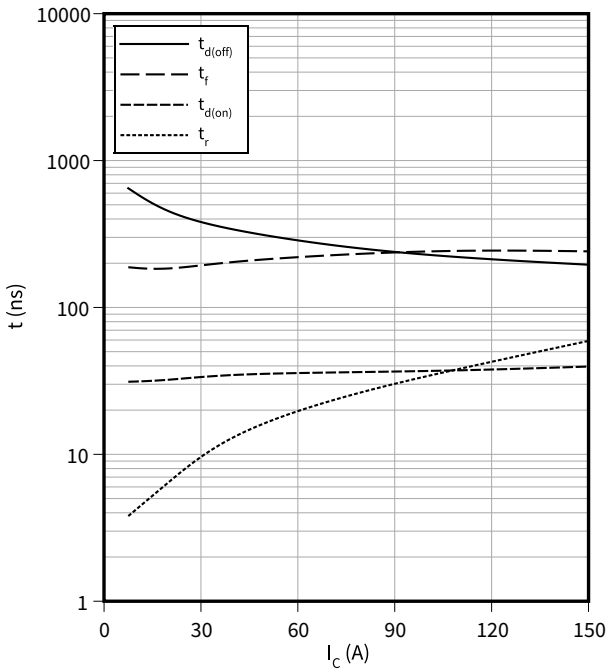
**Gate-emitter threshold voltage as a function of junction temperature**

$V_{GEth} = f(T_{vj})$   
 $I_c = 1.5\text{ mA}$



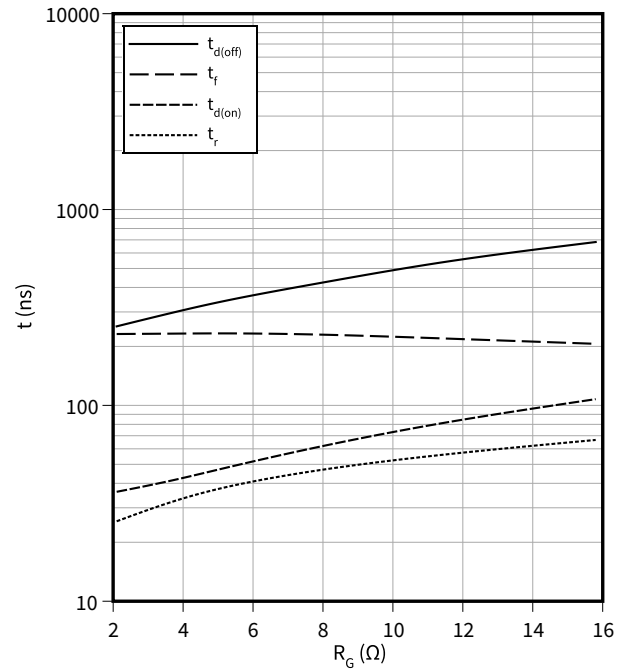
**Typical switching times as a function of collector current**

$t = f(I_c)$   
 $V_{CC} = 600\text{ V}, T_{vj} = 175\text{ °C}, V_{GE} = 0/15\text{ V}, R_G = 2.1\text{ }\Omega$



**Typical switching times as a function of gate resistor**

$t = f(R_G)$   
 $I_c = 75\text{ A}, V_{CC} = 600\text{ V}, T_{vj} = 175\text{ °C}, V_{GE} = 0/15\text{ V}$



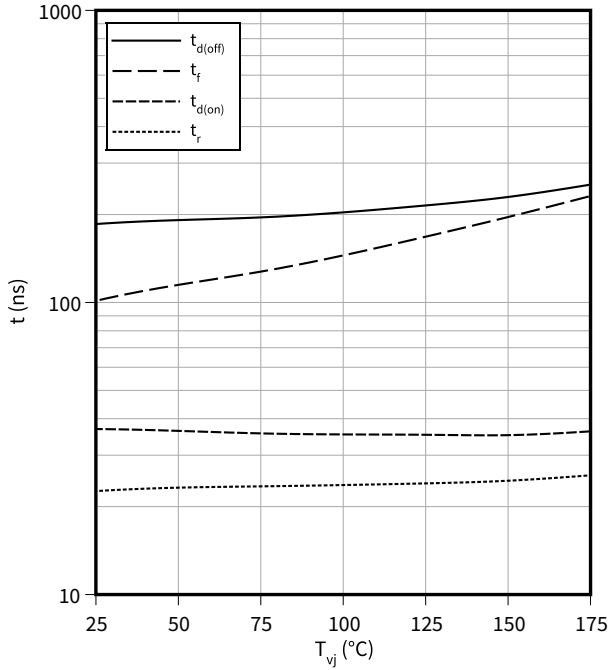


4 Characteristics diagrams

**Typical switching times as a function of junction temperature**

$t = f(T_{vj})$

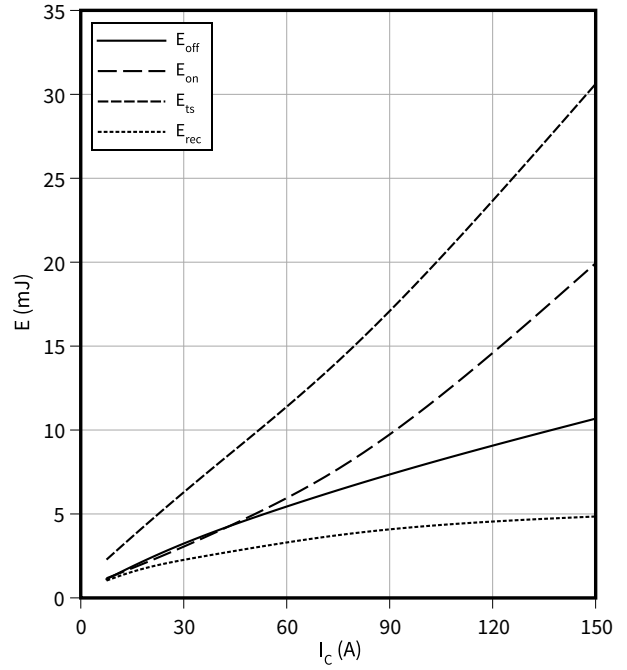
$I_C = 75 \text{ A}, V_{CC} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}, R_G = 2.1 \Omega$



**Typical switching energy losses as a function of collector current**

$E = f(I_C)$

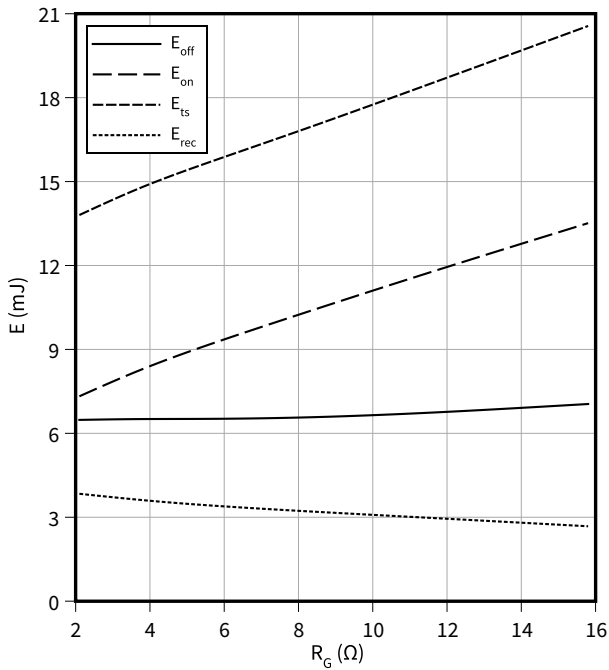
$V_{CC} = 600 \text{ V}, T_{vj} = 175 \text{ °C}, V_{GE} = 0/15 \text{ V}, R_G = 2.1 \Omega$



**Typical switching energy losses as a function of gate resistor**

$E = f(R_G)$

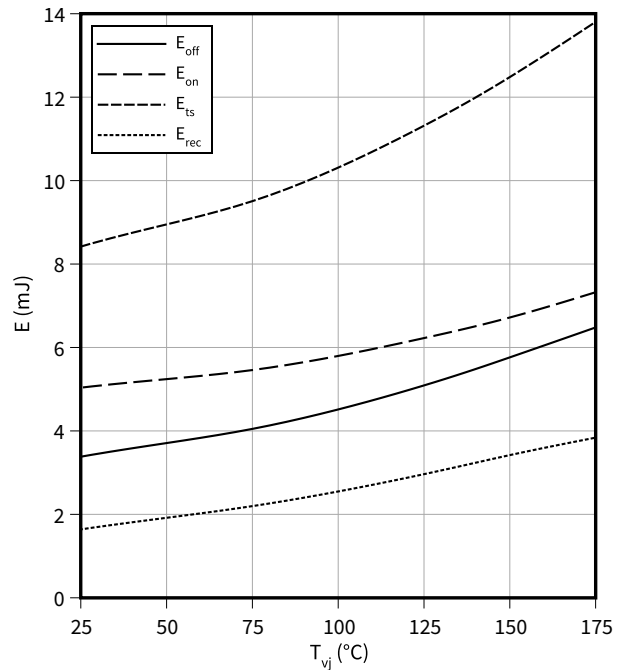
$I_C = 75 \text{ A}, V_{CC} = 600 \text{ V}, T_{vj} = 175 \text{ °C}, V_{GE} = 0/15 \text{ V}$



**Typical switching energy losses as a function of junction temperature**

$E = f(T_{vj})$

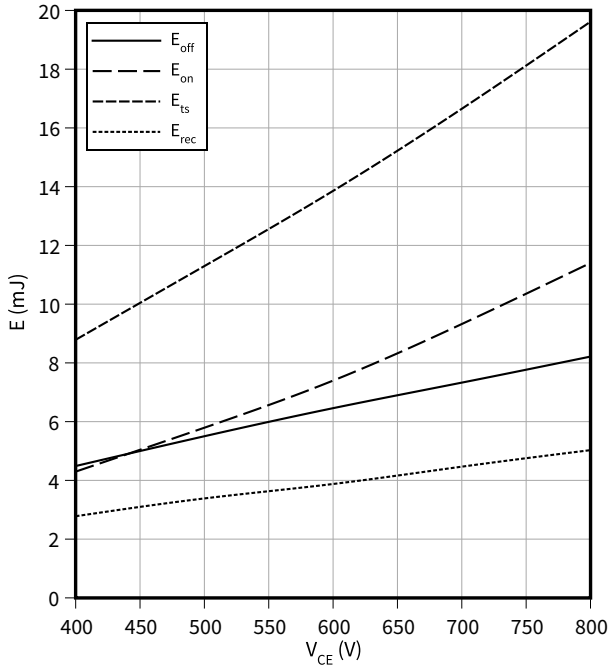
$I_C = 75 \text{ A}, V_{CC} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}, R_G = 2.1 \Omega$



**Typical switching energy losses as a function of collector emitter voltage**

$E = f(V_{CE})$

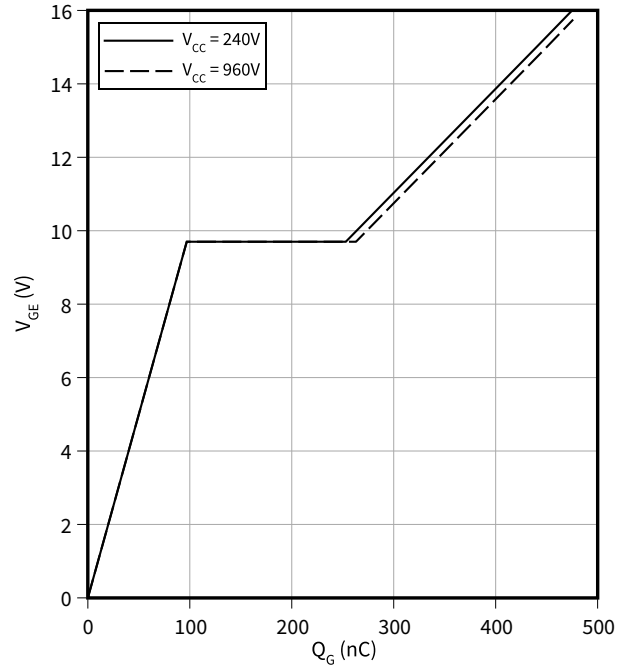
$I_C = 75 \text{ A}$ ,  $T_{vj} = 175 \text{ °C}$ ,  $V_{GE} = 0/15 \text{ V}$ ,  $R_G = 2.1 \text{ } \Omega$



**Typical gate charge**

$V_{GE} = f(Q_G)$

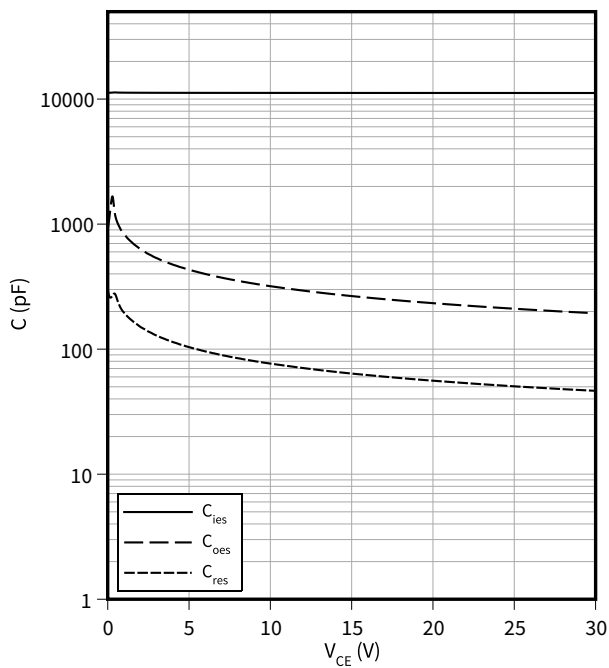
$I_C = 75 \text{ A}$



**Typical capacitance as a function of collector-emitter voltage**

$C = f(V_{CE})$

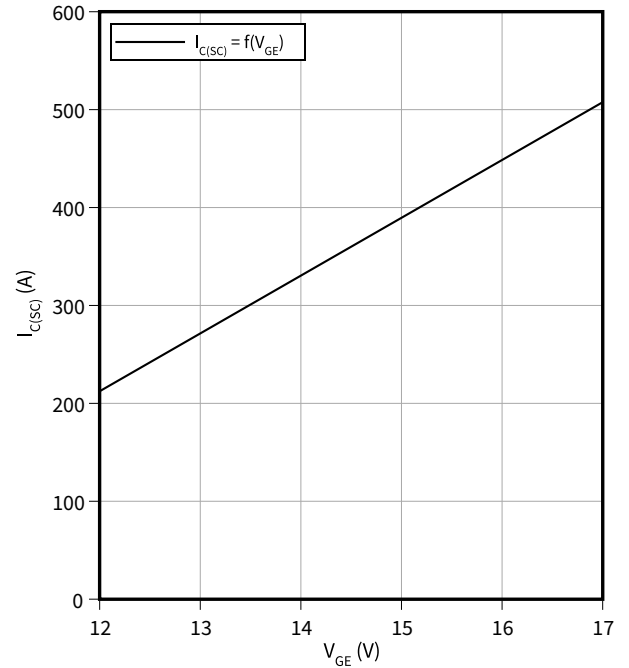
$f = 100 \text{ kHz}$ ,  $V_{GE} = 0 \text{ V}$



**Typical short circuit collector current as a function of gate-emitter voltage**

$I_{C(SC)} = f(V_{GE})$

$T_{vj} = 150 \text{ °C}$ ,  $V_{CC} \leq 600 \text{ V}$

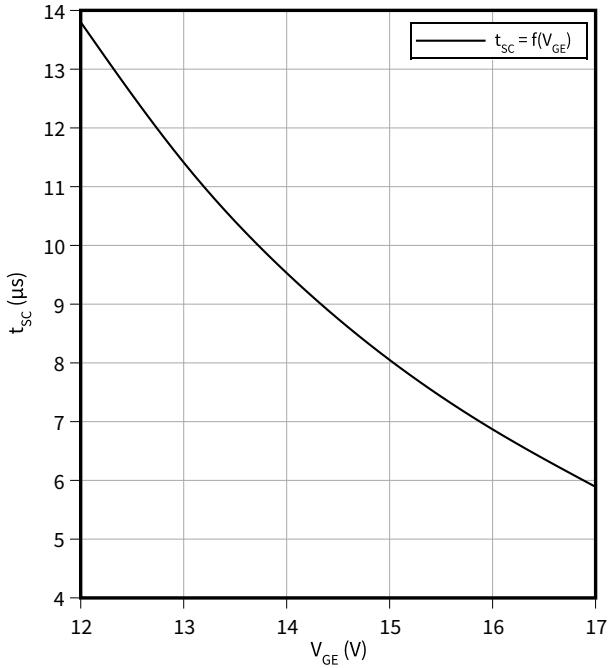


4 Characteristics diagrams

**Short circuit withstand time as a function of gate-emitter voltage**

$t_{SC} = f(V_{GE})$

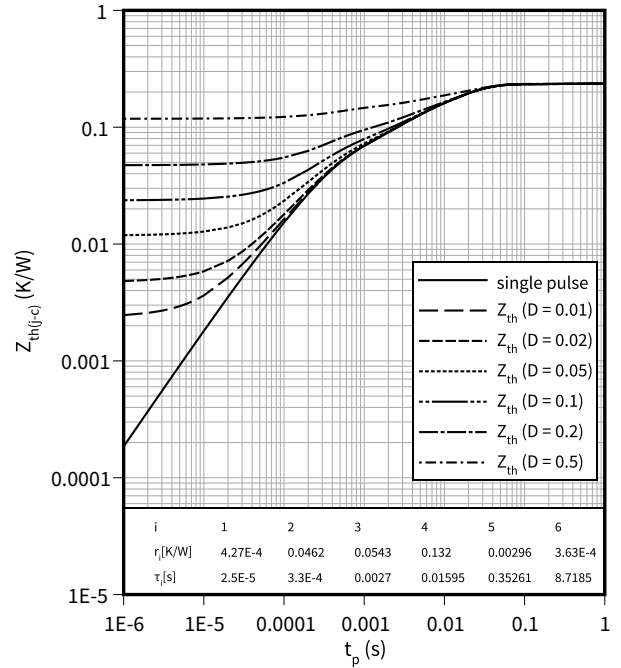
$T_{vj} \leq 150\text{ °C}, V_{CC} \leq 600\text{ V}$



**IGBT transient thermal impedance as a function of pulse width**

$Z_{th(j-c)} = f(t_p)$

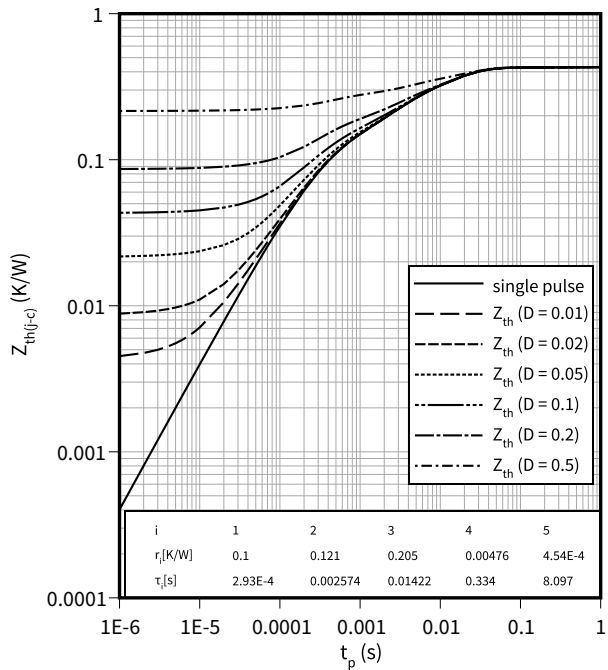
$D = t_p/T$



**Diode transient thermal impedance as a function of pulse width**

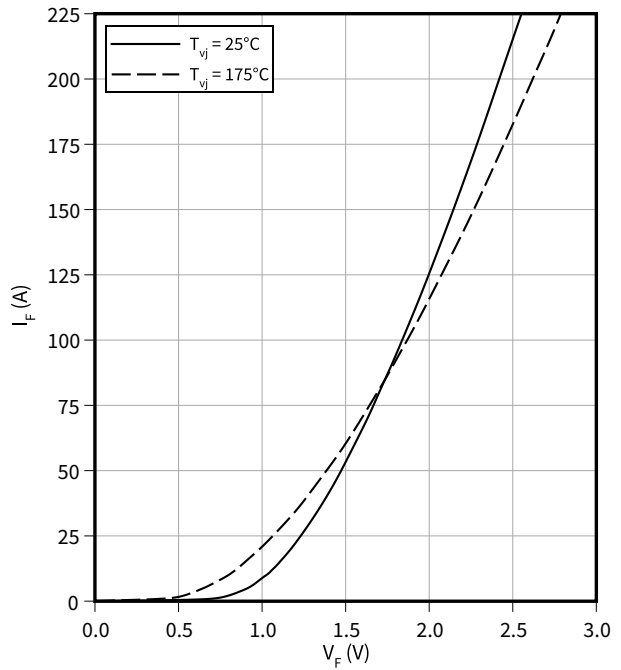
$Z_{th(j-c)} = f(t_p)$

$D = t_p/T$



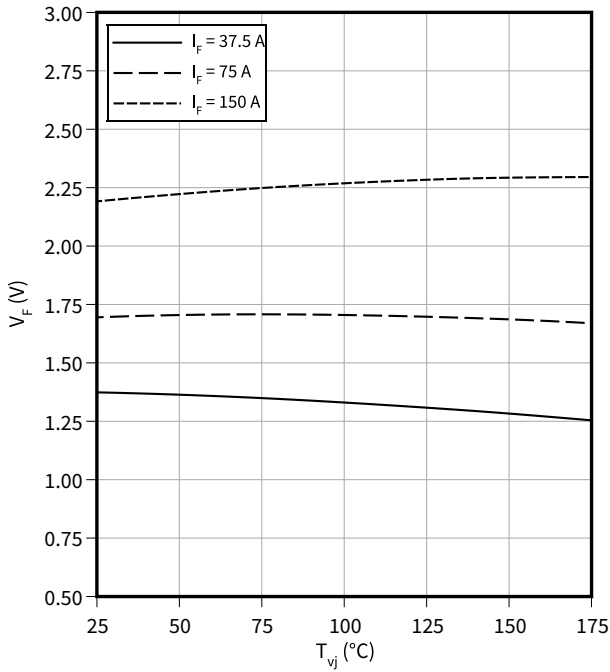
**Typical diode forward current as a function of forward voltage**

$I_F = f(V_F)$



**Typical diode forward voltage as a function of junction temperature**

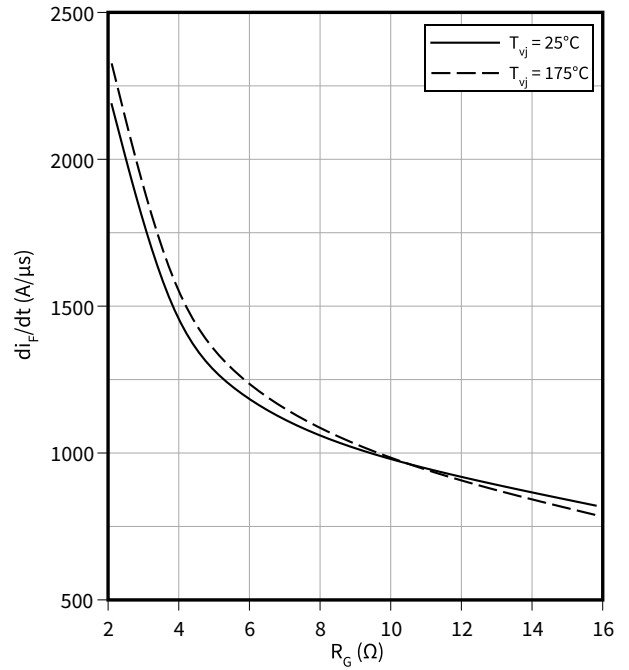
$V_F = f(T_{vj})$



**Typical diode current slope as a function of gate resistor**

$di_F/dt = f(R_G)$

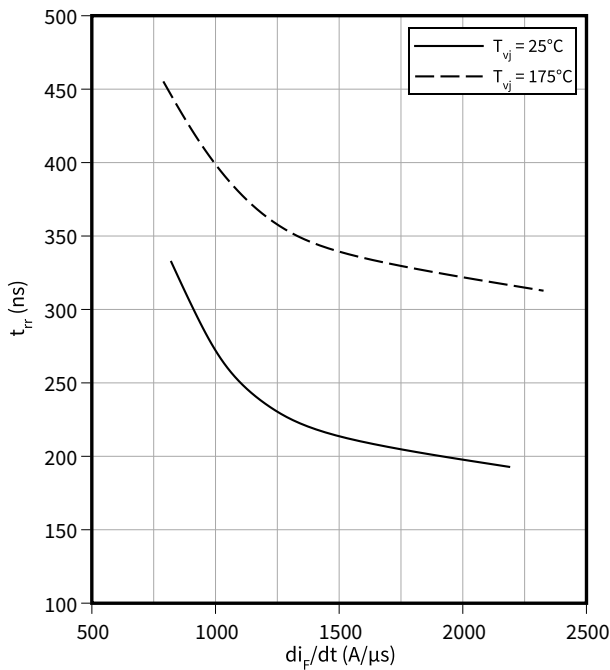
$V_R = 600$  V,  $I_F = 75$  A



**Typical reverse recovery time as a function of diode current slope**

$t_{rr} = f(di_F/dt)$

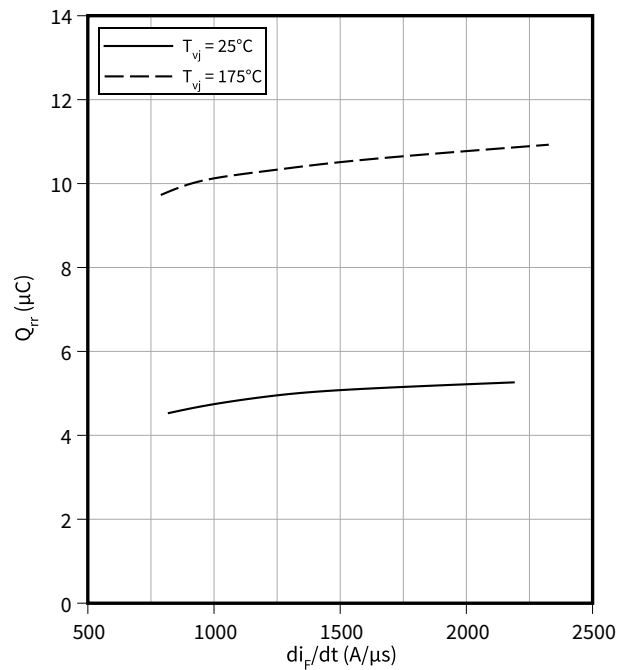
$V_R = 600$  V,  $I_F = 75$  A



**Typical reverse recovery charge as a function of diode current slope**

$Q_{rr} = f(di_F/dt)$

$V_R = 600$  V,  $I_F = 75$  A

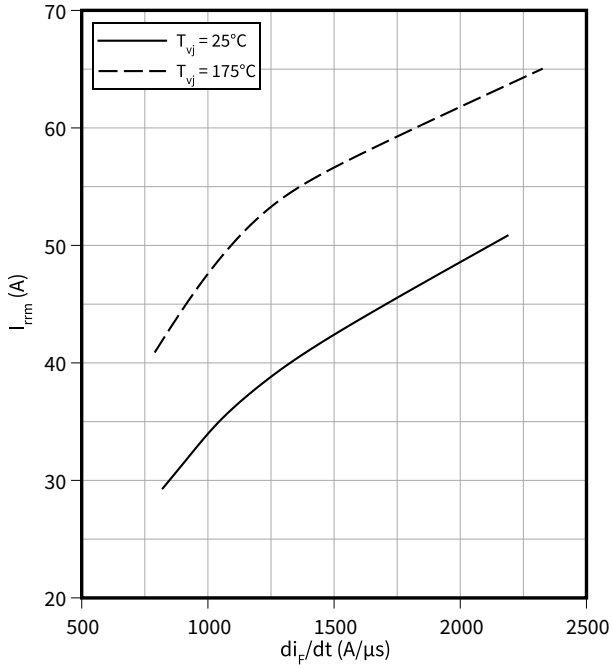


4 Characteristics diagrams

**Typical reverse recovery current as a function of diode current slope**

$$I_{rrm} = f(di_F/dt)$$

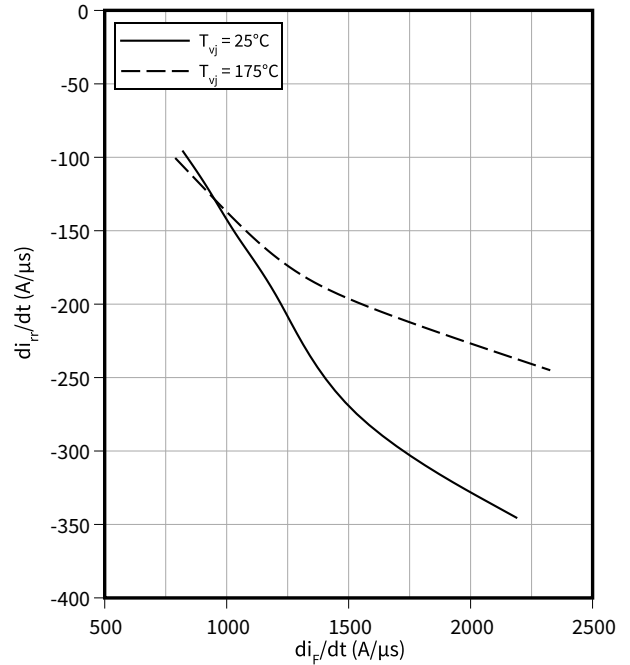
$V_R = 600\text{ V}, I_F = 75\text{ A}$



**Typical diode peak rate of fall of reverse recovery current as a function of diode current slope**

$$di_{rr}/dt = f(di_F/dt)$$

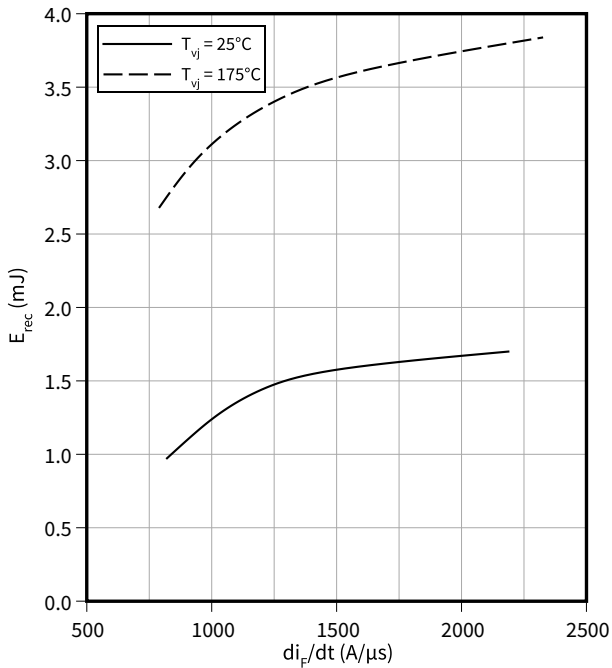
$V_R = 600\text{ V}, I_F = 75\text{ A}$



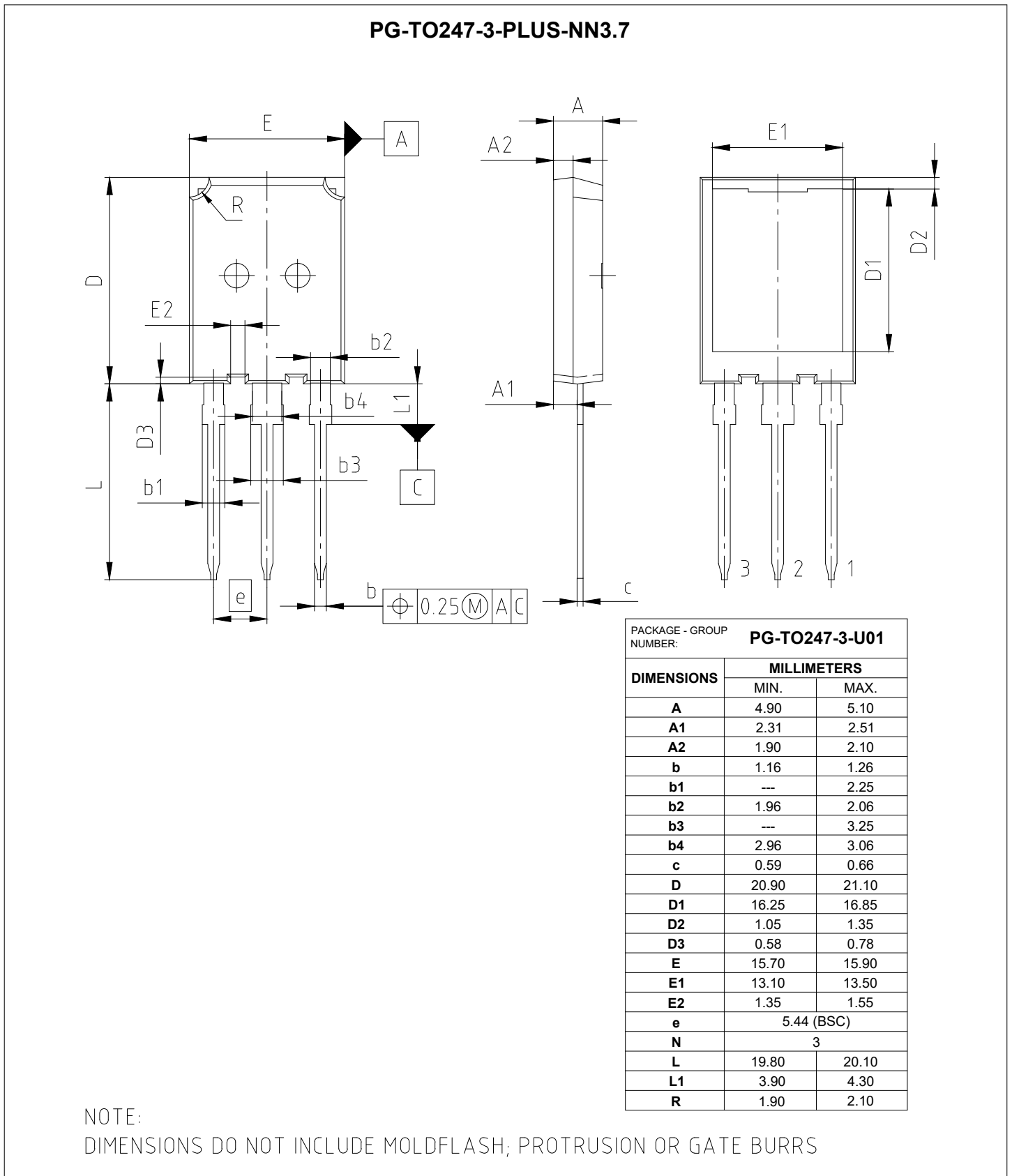
**Typical reverse energy losses as a function of diode current slope**

$$E_{rec} = f(di_F/dt)$$

$V_R = 600\text{ V}, I_F = 75\text{ A}$



**5 Package outlines**



**Figure 1**

**6 Testing conditions**



**Figure 2**

## Revision history

Document revision	Date of release	Description of changes
0.10	2022-05-04	Target datasheet
1.00	2022-12-05	Final datasheet
1.10	2023-01-23	Correction of boundary condition of diagrams $I_{C(SC)} = f(V_{GE})$ and $t_{SC} = f(V_{GE})$ Change of product outline drawing on page 14



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**Edition 2023-01-23**

**Published by**

**Infineon Technologies AG**

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**Document reference**

**IFX-ABB782-003**

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